



# Dual, Serial Input 14-Bit Multiplying Digital-to-Analog Converter

# **FEATURES**

- Relative Accuracy: 1 LSB Max
- Differential Nonlinearity: 1 LSB Max
- 2-mA Full-Scale Current ±20%, with V<sub>REF</sub> = ±10 V
- 0.5 μs Settling Time
- Midscale or Zero-Scale Reset
- Separate 4Q Multiplying Reference Inputs
- Reference Bandwidth: 10 MHz
- Reference Dynamics: –105 dB THD
- SPI™-Compatible 3-Wire Interface:
   50 MHz
- Double Buffered Registers to Enable Simultaneous Multichannel Update
- Internal Power-On Reset
- Industry-Standard Pin Configuration

## **APPLICATIONS**

- Automatic Test Equipment
- Instrumentation
- Digitally Controlled Calibration

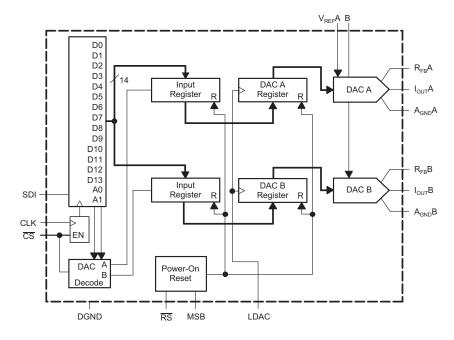
### DESCRIPTION

The DAC8802 is a dual, 14-bit, current-output digital-to-analog converter (DAC) designed to operate from a single 2.7 V to 5.5 V supply.

The applied external reference input voltage  $V_{REF}$  determines the full-scale output current. An internal feedback resistor ( $R_{FB}$ ) provides temperature tracking for the full-scale output when combined with an external I-to-V precision amplifier.

A doubled-buffered, serial data interface offers high-speed. 3-wire. SPI and microcontroller compatible inputs using serial data in (SDI), clock (CLK), and a chip-select ( $\overline{CS}$ ). A common level-sensitive load DAC strobe (LDAC) input allows simultaneous update of all DAC outputs from previously loaded input registers. Additionally, an internal power-on reset forces the output voltage to zero at system turn-on. An MSB pin allows system reset assertion (RS) to force all registers to zero code when MSB = 0, or to half-scale code when MSB = 1.

The DAC8802 is available in an TSSOP-16 package.



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This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

# PACKAGE/ORDERING INFORMATION(1)

PRODUCT	MINIMUM RELATIVE ACCURACY (LSB)	DIFFERENTIAL NONLINEARITY (LSB)	SPECIFIED TEMPERATURE RANGE	PACKAGE- LEAD	PACKAGE DESIGNATOR	ORDERING NUMBER	TRANSPORT MEDIA, QUANTITY
DA C8802	14	14	-40°C to 85°C	TSSOP-16	PW	DAC8802IPW	Tubes, 90
DAC8802	±1	±1	-40 C 10 85°C	1330P-16	FVV	DAC8802IPWR	Tape and Reel, 2500

For the most current specifications and package information, see the Package Option Addendum located at the end of this document, or see the TI website at www.ti.com.

# **ABSOLUTE MAXIMUM RATINGS**(1)

		DAC8802	UNIT
V <sub>DD</sub> to GN	ND	-0.3 to 7	V
V <sub>REF</sub> X, R <sub>F</sub>	<sub>B</sub> X to GND	-18 to 18	V
Digital log	ic inputs to GND	$-0.3 \text{ to + V}_{DD} + 0.3$	V
V(I <sub>OUT</sub> ) to	GND	- 0.3 to V <sub>DD</sub> + 0.3	V
$A_{\text{GND}}X$ to	DGND	-0.3 to +0.3	V
Input curre	ent to any pin except supplies	±50	mA
Package p	power dissipation	$(T_{J}max - T_{A})/\theta_{JA}$	W
Thermal re	esistance, θ <sub>JA</sub>	100	°C/W
Maximum	junction temperature (T <sub>J</sub> max)	150	°C
Operating	temperature range	- 40 to 85	°C
Storage te	emperature range	- 65 to 150	°C
ECD.	НВМ	4	kV
ESD	CDM	1	kV

<sup>(1)</sup> Stresses above those listed under absolute maximum ratings may cause permanent damage to the device. This is a stress rating only; functional operation of the device at these or any other conditions above those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum conditions for extended periods may affect device reliability.



# ELECTRICAL CHARACTERISTICS(1)

 $V_{DD}$  = 2.7 V to 5.5 V,  $I_{OUT}X$  = Virtual GND,  $A_{GND}X$  = 0 V,  $V_{REF}A$ , B = 10 V,  $T_A$  = full operating temperature range, unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
STATIC PERFORMANCE (2)			<del>-</del>		I	
Resolution					14	Bits
Relative accuracy	INL				±1	LSB
Differential nonlinearity	DNL				±1	LSB
Output Is also as assument	l V	Data = 0000h, T <sub>A</sub> = 25°C			10	nA
Output leakage current	I <sub>OUT</sub> X	Data = 0000h, $T_A = T_A \text{ max}$			20	nA
Full-scale gain error	G <sub>FSE</sub>	Data = 3FFFh	:	±0.75	±4	mV
Full-scale tempco <sup>(3)</sup>	TCV <sub>FS</sub>			1		ppm/°C
Feedback resistor	R <sub>FB</sub> X	V <sub>DD</sub> = 5 V		5		kΩ
REFERENCE INPUT(3)						
V <sub>REF</sub> X Range	V <sub>REF</sub> X		-15		15	V
Input resistance	R <sub>REF</sub> X		4	5	6	kΩ
Input resistance match	R <sub>REF</sub> X	Channel-to-channel		1		%
Input capacitance	C <sub>REF</sub> X			5		pF
ANALOG OUTPUT(3)						
Output current	I <sub>OUT</sub> X	Data = 3FFFh	1.6		2.5	mA
Output capacitance	C <sub>OUT</sub> X	Code-dependent		50		pF
LOGIC INPUTS(3)			·			
Innut law valtage	V	$V_{DD} = 2.7 \text{ V}$			0.6	V
Input low voltage	V <sub>IL</sub>	V <sub>DD</sub> = 5 V			0.8	V
lanut high voltage	\/	V <sub>DD</sub> = 2.7 V	2.1			V
Input high voltage	V <sub>IH</sub>	V <sub>DD</sub> = 5 V	2.4			V
Input leakage current	I <sub>IL</sub>				1	μΑ
Input capacitance	C <sub>IL</sub>				10	pF
INTERFACE TIMING (4)			·			
Clock width high	t <sub>CH</sub>		10			ns
Clock width low	t <sub>CL</sub>		10			ns
CS to Clock setup	t <sub>CSS</sub>		0			ns
Clock to CS hold	t <sub>CSH</sub>		10			ns
Clock to SDO prop delay	t <sub>PD</sub>		2		20	ns
Load DAC pulsewidth	t <sub>LDAC</sub>		20			ns
Data setup	t <sub>DS</sub>		10			ns
Data hold	t <sub>DH</sub>		10			ns
Load setup	t <sub>LDS</sub>		5			ns
Load hold	t <sub>LDH</sub>		25			ns

Specifications subject to change without notice.

All static performance tests (except I<sub>OUT</sub>) are performed in a closed-loop system using an external precision OPA277 I-to-V converter amplifier. The DAC8802 R<sub>FB</sub> terminal is tied to the amplifier output. Typical values represent average readings measured at +25°C. These parameters are specified by design and not subject to production testing.

<sup>(4)</sup> All input control signals are specified with t<sub>R</sub> = t<sub>F</sub> = 2.5 ns (10% to 90% of 3 V) and timed from a voltage level of 1.5 V.



# **ELECTRICAL CHARACTERISTICS (continued)**

 $V_{DD}$  = 2.7 V to 5.5 V,  $I_{OUT}X$  = Virtual GND,  $A_{GND}X$  = 0 V,  $V_{REF}A$ , B = 10 V,  $T_A$  = full operating temperature range, unless otherwise noted.

PARAMETER	SYMBOL	CONDITIONS	MIN	TYP	MAX	UNIT
SUPPLY CHARACTERISTICS	<b>)</b>	1				
Power supply range	V <sub>DD RANGE</sub>		2.7		5.5	V
Desitive supply surrent		Logic inputs = 0 V, $V_{DD}$ = 4.5 V to 5.5 V		2	5	μΑ
Positive supply current	I <sub>DD</sub>	Logic inputs = 0 V, $V_{DD}$ = 2.7 V to 3.6 V		1	2.5	μΑ
Power dissipation	P <sub>DISS</sub>	Logic inputs = 0 V			0.0275	mW
Power supply sensitivity	P <sub>SS</sub>	$\Delta V_{DD} = \pm 5\%$			0.006	%
AC CHARACTERISTICS (5)(6)						
O. 45 4 14		To $\pm 0.1\%$ of full-scale, Data = 0000h to 3FFFh to 0000h		0.3		μs
Output voltage settling time	t <sub>s</sub>	To ±0.006% of full-scale, Data = 0000h to 3FFFh to 0000h		0.5		μs
Reference multiplying BW	BW -3 dB	$V_{REF}X = 100 \text{ mV}_{RMS}$ , Data = 3FFFh, $C_{FB} = 3 \text{ pF}$		10		MHz
DAC glitch impulse	Q	V <sub>REF</sub> X = 10 V, Data = 1FFFh to 2000h to 1FFFh		5		nV/s
Feedthrough error	V <sub>OUT</sub> X/V <sub>REF</sub> X	Data = 0000h, V <sub>REF</sub> X = 100 mV <sub>RMS</sub> , f = 100 kHz		-70		dB
Crosstalk error	V <sub>OUT</sub> A/V <sub>REF</sub> B	Data = 0000h, V <sub>REF</sub> B = 100 mV <sub>RMS</sub> , Adjacent channel, f = 100 kHz		-100		dB
Digital feedthrough	Q	CS = 1 and f <sub>CLK</sub> = 1 MHz		1		nV/s
Total harmonic distortion	THD	$V_{REF} = 5 V_{PP}$ , Data = 3FFFh, f = 1 kHz		-105		dB
Output spot noise voltage	e <sub>n</sub>	f = 1 kHz, BW = 1 Hz		12		nV/√ <del>Hz</del>

- (5) These parameters are specified by design and not subject to production testing.(6) All ac characteristic tests are performed in a closed-loop system using an THS4011 I-to-V converter amplifier.

# PARAMETER MEASUREMENT INFORMATION

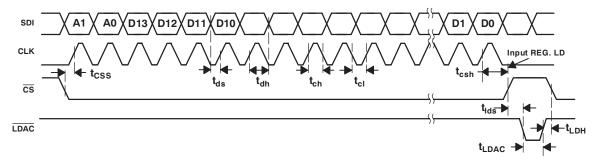
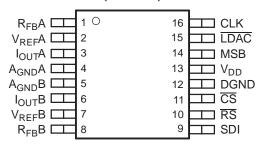


Figure 1. DAC8802 Timing Diagram



# **PIN CONFIGURATIONS**

# DAC8802 (TOP VIEW)



# **PIN DESCRIPTION**

PIN	NAME	DESCRIPTION
1	R <sub>FB</sub> A	Establish voltage output for DAC A by connecting to external amplifier output.
2	V <sub>REF</sub> A	DAC A Reference voltage input terminal. Establishes DAC A full-scale output voltage. Can be tied to V <sub>DD</sub> pin.
3	I <sub>OUT</sub> A	DAC A Current output.
4	$A_{GND}A$	DAC A Analog ground.
5	A <sub>GND</sub> B	DAC B Analog ground.
6	I <sub>OUT</sub> B	DAC B Current output.
7	V <sub>REF</sub> B	DAC B Reference voltage input terminal. Establishes DAC B full-scale output voltage. Can be tied to V <sub>DD</sub> pin.
8	R <sub>FB</sub> B	Establish voltage output for DAC B by connecting to external amplifier output.
9	SDI	Serial data input; data loads directly into the shift register.
10	RS	Reset pin; active low input. Input registers and DAC registers are set to all 0s or midscale. Register data = 0x0000 when MSB = 0. Register data = 0x2000 when MSB = 1 for DAC8802.
11	CS	Chip-select; active low input. Disables shift register loading when high. Transfers serial register data to input register when $\overline{\text{CS}}$ goes high. Does not affect $\overline{\text{LDAC}}$ operation.
12	DGND	Digital ground.
13	$V_{DD}$	Positive power-supply input. Specified range of operation is 2.7 V to 5.5 V.
14	MSB	MSB bit sets output to either 0 or midscale during a RESET pulse $(\overline{RS})$ or at system power-on. Output equals zero scale when MSB = 0 and midscale when MSB = 1. MSB pin can be permanently tied to ground or $V_{DD}$ .
15	LDAC	Load DAC register strobe; level sensitive active low. Transfers all input register data to the DAC registers. Asynchronous active low input. See Table 2 for operation.
16	CLK	Clock input. Positive edge clocks data into shift register.



# TYPICAL CHARACTERISTICS: V<sub>DD</sub> = 5 V

At  $T_A = 25$ °C,  $+V_{DD} = 5$  V, unless otherwise noted.

## Channel A

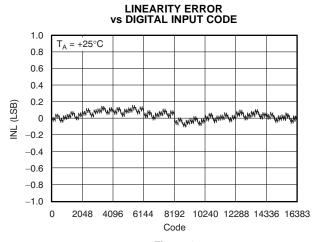


Figure 2.

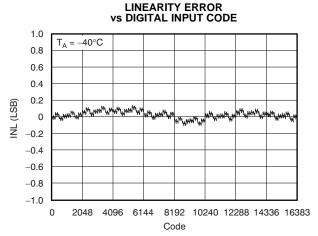


Figure 4.

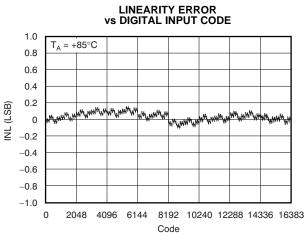


Figure 6.

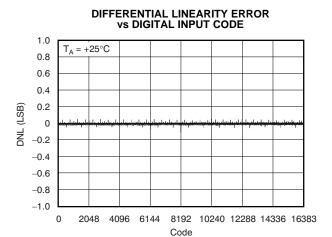


Figure 3.

# DIFFERENTIAL LINEARITY ERROR VS DIGITAL INPUT CODE

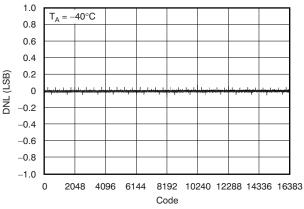


Figure 5.

# DIFFERENTIAL LINEARITY ERROR vs DIGITAL INPUT CODE

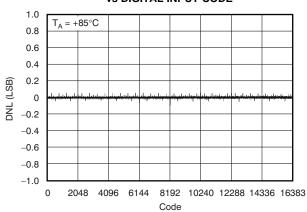


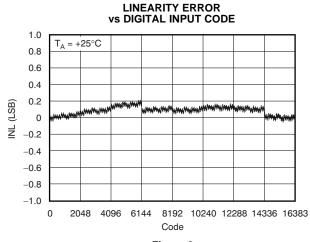
Figure 7.



# TYPICAL CHARACTERISTICS: $V_{DD} = 5 \text{ V (continued)}$

At  $T_A = 25$ °C,  $+V_{DD} = 5$  V, unless otherwise noted.

### Channel B



#### Figure 8.

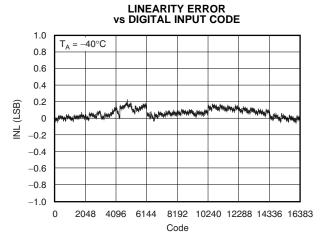


Figure 10.

LINEARITY ERROR

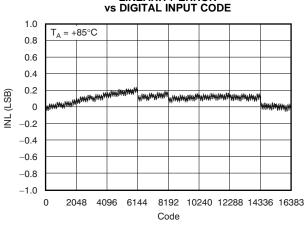


Figure 12.

# DIFFERENTIAL LINEARITY ERROR VS DIGITAL INPUT CODE

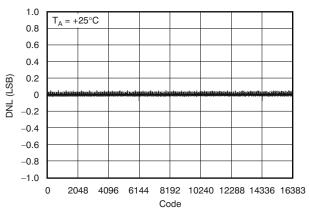


Figure 9.

# DIFFERENTIAL LINEARITY ERROR VS DIGITAL INPUT CODE

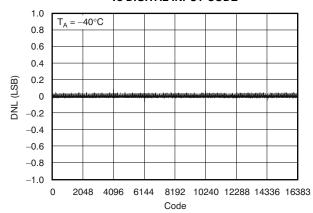


Figure 11.

# DIFFERENTIAL LINEARITY ERROR vs DIGITAL INPUT CODE

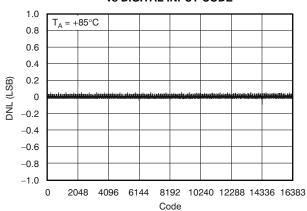
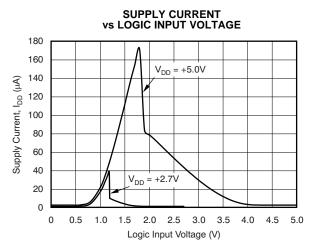


Figure 13.



# TYPICAL CHARACTERISTICS: V<sub>DD</sub> = 5 V (continued)

At  $T_A = 25$ °C, + $V_{DD} = 5$  V, unless otherwise noted.



#### Figure 14.

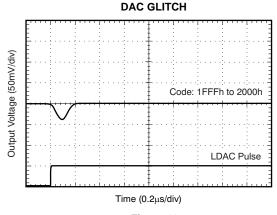


Figure 16.

### REFERENCE MULTIPLYING BANDWIDTH

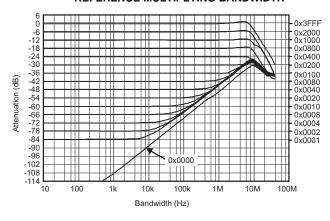


Figure 15.



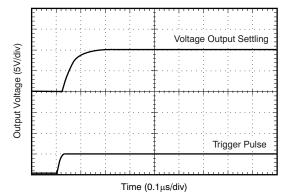


Figure 17.



# TYPICAL CHARACTERISTICS: V<sub>DD</sub> = 2.7 V

At  $T_A = 25$ °C, + $V_{DD} = 2.7$  V, unless otherwise noted.

## Channel A

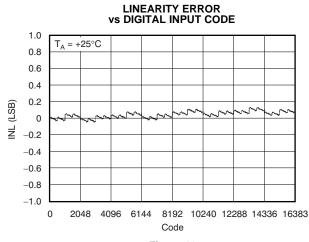


Figure 18.

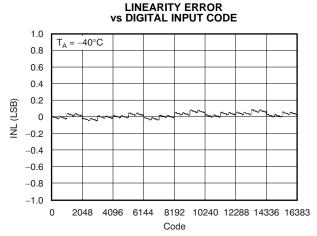


Figure 20.

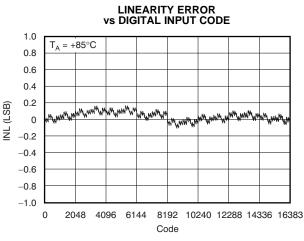


Figure 22.

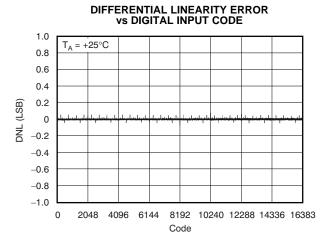


Figure 19.

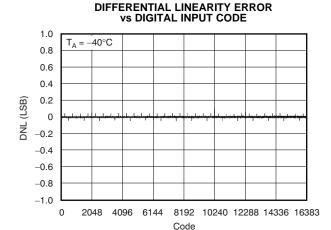


Figure 21.

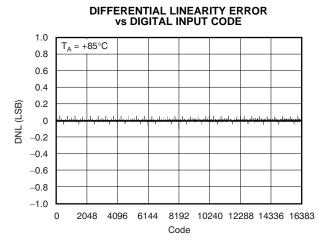


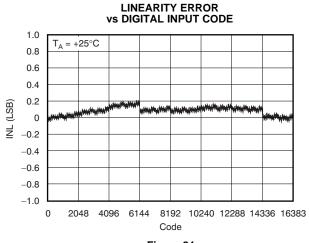
Figure 23.



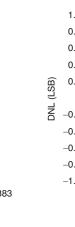
# TYPICAL CHARACTERISTICS: V<sub>DD</sub> = 2.7 V (continued)

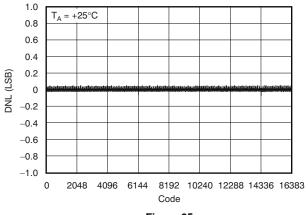
At  $T_A = 25$ °C, + $V_{DD} = 2.7$  V, unless otherwise noted.

### Channel B



#### Figure 24.





**DIFFERENTIAL LINEARITY ERROR** 

**vs DIGITAL INPUT CODE** 

Figure 25.

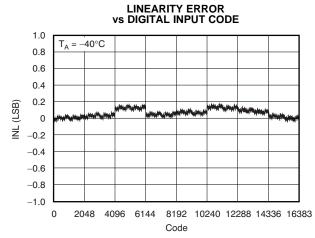


Figure 26.

# **DIFFERENTIAL LINEARITY ERROR VS DIGITAL INPUT CODE**

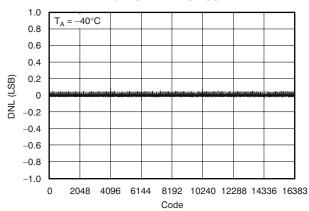


Figure 27.

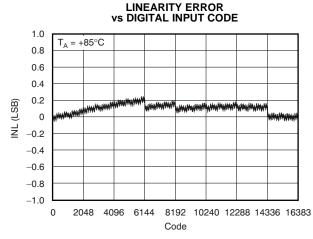


Figure 28.

#### DIFFERENTIAL LINEARITY ERROR **vs DIGITAL INPUT CODE**

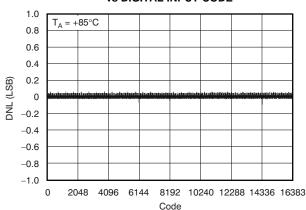


Figure 29.



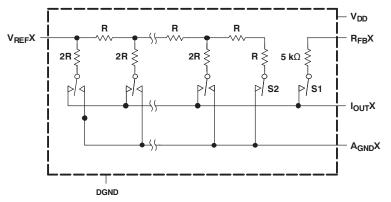
### THEORY OF OPERATION

### CIRCUIT OPERATION

The DAC8802 contains two 14-bit, current-output, digital-to-analog converters (DACs). Each DAC has its own independent multiplying reference input. The DAC8802 uses a 3-wire, SPI-compatible serial data interface, with a configurable asynchronous  $\overline{RS}$  pin for half-scale (MSB = 1) or zero-scale (MSB = 0) preset. In addition, an  $\overline{LDAC}$  strobe enables two-channel simultaneous updates for hardware-synchronized output voltage changes.

## **Digital-to-Analog Converters**

The DAC8802 contains two current-steering R-2R ladder DACs. Figure 30 shows a typical equivalent DAC. Each DAC contains a matching feedback resistor for use with an external I-to-V converter amplifier. The  $R_{FB}X$  pin is connected to the output of the external amplifier. The  $I_{OUT}X$  terminal is connected to the inverting input of the external amplifier. The  $A_{GND}X$  pin should be Kelvin-connected to the load point in the circuit requiring the full 14-bit accuracy.



Digital interface connections are omitted for clarity. Switches S1 and S2 are closed;  $V_{\rm DD}$  must be powered.

Figure 30. Typical Equivalent DAC Channel

The DAC is designed to operate with both negative or positive reference voltages. The  $V_{DD}$  power pin is only used by the logic to drive the DAC switches on and off. Note that a matching switch is used in series with the internal 5 k $\Omega$  feedback resistor. If users are attempting to measure the value of  $R_{FB}$ , power must be applied to  $V_{DD}$  in order to achieve continuity. The DAC output voltage is determined by  $V_{REF}$  and the digital data (D) according to Equation 1:

$$V_{OUT} = -V_{REF} \times \frac{D}{16384} \tag{1}$$

Note that the output polarity is opposite of the V<sub>RFF</sub> polarity for dc reference voltages.

The DAC is also designed to accommodate ac reference input signals. The DAC8802 accommodates input reference voltages in the range of -15 V to 15 V. The reference voltage inputs exhibit a constant nominal input resistance of 5 k $\Omega$ ,  $\pm 20\%$ . On the other hand, DAC outputs I<sub>OUT</sub>A and B are code-dependent and produce various output resistances and capacitances.

The choice of external amplifier should take into account the variation in impedance generated by the DAC8802 on the amplifiers' inverting input node. The feedback resistance, in parallel with the DAC ladder resistance, dominates output voltage noise. For multiplying mode applications, an external feedback compensation capacitor, C<sub>FB</sub> (4 pF to 20 pF typical), may be needed to provide a critically damped output response for step changes in reference input voltages.



Figure 15 shows the gain vs frequency performance at various attenuation settings using a 3 pF external feedback capacitor connected across the  $I_{OUT}X$  and  $R_{FB}X$  terminals. In order to maintain good analog performance, power supply bypassing of 0.01  $\mu$ F, in parallel with 1  $\mu$ F, is recommended. Under these conditions, a clean power supply with low ripple voltage capability should be used. Switching power supplies is usually not suitable for this application due to the higher ripple voltage and  $P_{SS}$  frequency-dependent characteristics. It is best to derive the DAC8802 5-V supply from the system analog supply voltages (do not use the digital 5-V supply); see Figure 31.

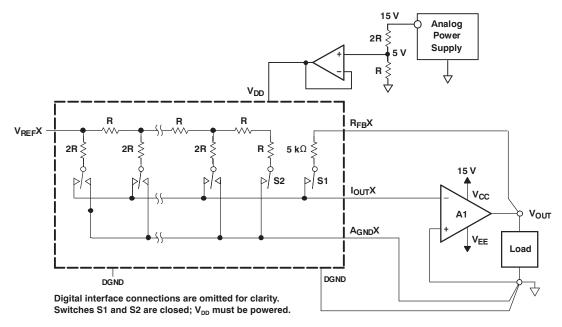


Figure 31. Recommended Kelvin-Sensed Hookup

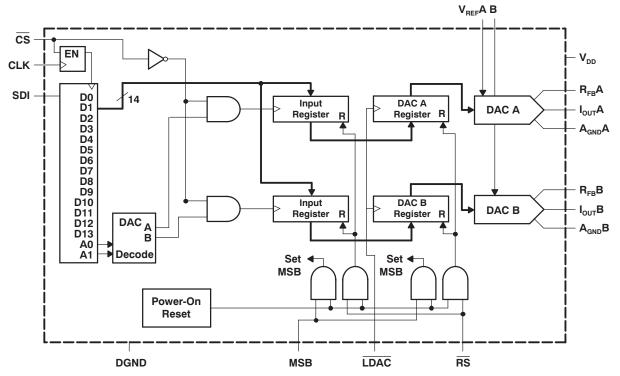


Figure 32. System Level Digital Interfacing



### **SERIAL DATA INTERFACE**

The DAC8802 uses a 3-wire ( $\overline{\text{CS}}$ , SDI, CLK) SPI-compatible serial data interface. Serial data of the DAC8802 is clocked into the serial input register in an 16-bit data-word format. MSB bits are loaded first. Table 1 defines the 16 data-word bits for the DAC8802.

Data is placed on the SDI pin, and clocked into the register on the positive clock edge of CLK subject to the data setup and data hold time requirements specified in the *Interface Timing* specifications of the Electrical Characteristics. Data can only be clocked in while the  $\overline{\text{CS}}$  chip select pin is active low. For the DAC8802, only the last 16 bits clocked into the serial register are interrogated when the  $\overline{\text{CS}}$  pin returns to the logic high state.

Since most microcontrollers output serial data in 8-bit bytes, two right-justified data bytes can be written to the DAC8802. Keeping the  $\overline{\text{CS}}$  line low between the first and second byte transfer will result in a successful serial register update.

Once the data is properly aligned in the shift register, the positive edge of the  $\overline{CS}$  initiates the transfer of new data to the target DAC register, determined by the decoding of address bits A1and A0. For the DAC8802, Table 1, Table 2, Table 3, and Figure 1 define the characteristics of the software serial interface.

Table 1. Serial Input Register Data Format, Data Loaded MSB First<sup>(1)</sup>

Bit	B15	B14	B13	B12	B11	B10	B9	B8	B7	В6	B5	B4	В3	B2	B1	B0 (LSB)
Data	A1	A0	D13	D12	D11	D10	D9	D8	D7	D6	D5	D4	D3	D2	D1	D0

(1) Only the last 16 bits of data clocked into the serial register (address + data) are inspected when the CS line positive edge returns to logic high. At this point an internally-generated load strobe transfers the serial register data contents (bits D13-D0) to the decoded DAC-input-register address determined by bits A1 and A0. Any extra bits clocked into the DAC8802 shift register are ignored; only the last 16 bits clocked in are used. If double-buffered data is not needed, the LDAC pin can be tied logic low to disable the DAC registers.

Table 2. Control Logic Truth Table<sup>(1)</sup>

CS	CLK	LDAC	RS	MSB	SERIAL SHIFT REGISTER	INPUT REGISTER	DAC REGISTER
Н	Χ	Н	Н	X	No effect	Latched	Latched
L	L	Н	Н	Х	No effect	Latched	Latched
L	+	Н	Н	X	Shift register data advanced one bit	Latched	Latched
L	Н	Н	Н	Х	No effect	Latched	Latched
<b>↑</b> +	L	Н	Н	Х	No effect	Selected DAC updated with current SR contents	Latched
Н	Χ	L	Н	X	No effect	Latched	Transparent
Н	Х	Н	Н	Х	No effect	Latched	Latched
Н	Χ	+↑	Н	Х	No effect	Latched	Latched
Н	Х	Н	L	0	No effect	Latched data = 0000h	Latched data = 0000h
Н	X	Н	L	Н	No effect	Latched data = 2000h	Latched data = 2000h

(1)  $\uparrow$  = Positive logic transition; X = Do not care

Table 3. Address Decode

A1	Α0	DAC DECODE
0	0	None
0	1	DAC A
1	0	DAC B
1	1	DAC A and DAC B



Figure 33 shows the equivalent logic interface for the key digital control pins for the DAC8802.

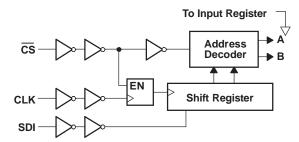


Figure 33. DAC8802 Equivalent Logic Interface

Two additional pins  $\overline{RS}$  and MSB provide hardware control over the preset function and DAC register loading. If these functions are not needed, the  $\overline{RS}$  pin can be tied to logic high. The asynchronous input  $\overline{RS}$  pin forces all input and DAC registers to either the zero-code state (MSB = 0), or the half-scale state (MSB = 1).

### **POWER ON RESET**

When the  $V_{DD}$  power supply is turned on, an internal reset strobe forces all the Input and DAC registers to the zero-code state or half-scale, depending on the MSB pin voltage. The  $V_{DD}$  power supply should have a smooth positive ramp without drooping, in order to have consistent results, especially in the region of  $V_{DD} = 1.5 \text{ V}$  to 2.3 V. The DAC register data stays at the zero or half-scale setting until a valid serial register data load takes place.

#### **ESD Protection Circuits**

All logic-input pins contain back-biased ESD protection zener diodes connected to ground (DGND) and  $V_{DD}$ , as shown in Figure 34.

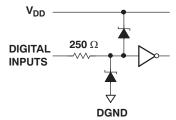


Figure 34. Equivalent ESD Protection Circuits

### **PCB LAYOUT**

The DAC8802 is a high-accuracy DAC that can have its performance compromised by grounding and printed circuit board (PCB) lead trace resistance. The 14-bit DAC8802 with a 10-V full-scale range has an LSB value of 610  $\mu$ V. The ladder and associated reference and analog ground currents for a given channel can be as high as 2 mA. With this 2 mA current level, a series wiring and connector resistance of only 305 m $\Omega$  will cause 1 LSB of voltage drop. The preferred PCB layout for the DAC8802 is to have all  $A_{GND}X$  pins connected directly to an analog ground plane at the unit. The noninverting input of each channel I/V converter should also either connect directly to the analog ground plane or have an individual sense trace back to the  $A_{GND}X$  pin connection. The feedback resistor trace to the I/V converter should also be kept short and low resistance to prevent IR drops from contributing to gain error. This attention to wiring ensures the optimal performance of the DAC8802.



## **APPLICATION INFORMATION**

The DAC8802, a 2-quadrant multiplying DAC, can be used to generate a unipolar output. The polarity of the full-scale output  $I_{OUT}$  is the inverse of the input reference voltage at  $V_{REF}$ .

Some applications require full 4-quadrant multiplying capabilities or bipolar output swing, as shown in Figure 35. An additional external op amp (A2) is added as a summing amp. In this circuit, the first and second amps (A1 and A2) provide a gain of 2X that widens the output span to 20 V. A 4-quadrant multiplying circuit is implemented by using a 10-V offset of the reference voltage to bias A2. According to the following circuit transfer equation (Equation 2), input data (D) from code 0 to full scale produces output voltages of  $V_{OUT} = -10 \text{ V}$  to  $V_{OUT} = 10 \text{ V}$ .

$$V_{OUT} = \left(\frac{D}{8192} - 1\right) \times V_{REF}$$

$$10 \text{ k}\Omega$$

$$V_{REF}$$

$$V_{DD}$$

$$V_{REF}X$$

$$V_{REF}X$$

$$V_{REF}X$$

$$V_{REF}X$$

$$V_{DD}$$

$$V_{REF}X$$

$$V_{REF}X$$

$$V_{DD}$$

$$V_{D$$

Digital interface connections omitted for clarity.

A. This figure represents one channel only. X is channel A or B (i.e.  $V_{REF} x = V_{REF} A$  or  $V_{REF} B$ )

Figure 35. Four-Quadrant Multiplying Application Circuit

# **Cross-Reference**

The DAC8802 has an industry-standard pinout. Table 4 provides the cross-reference information.

Table 4. Cross-Reference

PRODUCT	INL (LSB)	DNL (LSB)	SPECIFIED TEMPERATURE RANGE	PACKAGE DESCRIPTION	PACKAGE OPTION	CROSS-REFERENCE PART NUMBER
DAC8802IPW	±1	±1	-40°C to 85°C	16-Lead Thin Shrink Small-Outline Package	TSSOP-16	AD5555CRU

www.ti.com 4-May-2025

## PACKAGING INFORMATION

Orderable part number	Status	Material type	Package   Pins	Package qty   Carrier	RoHS	Lead finish/ Ball material	MSL rating/ Peak reflow	Op temp (°C)	Part marking (6)
						(4)	(5)		
DAC8802IPW	Active	Production	TSSOP (PW)   16	90   TUBE	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	DAC8802
DAC8802IPWR	Active	Production	TSSOP (PW)   16	2000   LARGE T&R	Yes	NIPDAU	Level-2-260C-1 YEAR	-40 to 85	DAC8802

<sup>(1)</sup> Status: For more details on status, see our product life cycle.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

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<sup>(3)</sup> RoHS values: Yes, No, RoHS Exempt. See the TI RoHS Statement for additional information and value definition.

<sup>(4)</sup> Lead finish/Ball material: Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

<sup>(6)</sup> Part marking: There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

# **PACKAGE MATERIALS INFORMATION**

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# TAPE AND REEL INFORMATION





A0	Dimension designed to accommodate the component width
В0	Dimension designed to accommodate the component length
K0	Dimension designed to accommodate the component thickness
W	Overall width of the carrier tape
P1	Pitch between successive cavity centers

# QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE

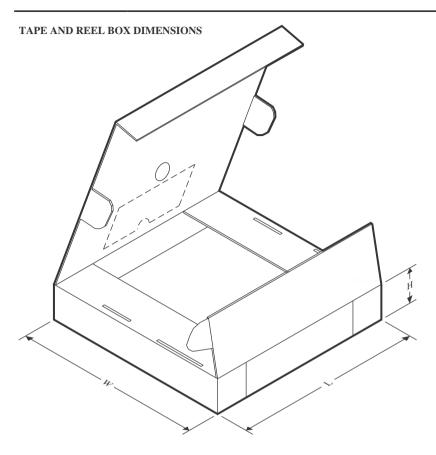


#### \*All dimensions are nominal

Device	U	Package Drawing		SPQ	Reel Diameter (mm)	Reel Width W1 (mm)	A0 (mm)	B0 (mm)	K0 (mm)	P1 (mm)	W (mm)	Pin1 Quadrant
DAC8802IPWR	TSSOP	PW	16	2000	330.0	12.4	6.9	5.6	1.6	8.0	12.0	Q1

# **PACKAGE MATERIALS INFORMATION**

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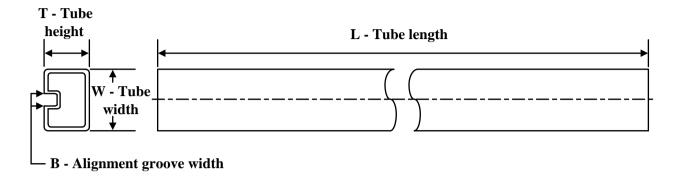
# \*All dimensions are nominal

Ì	Device	Package Type	Package Drawing	Pins	SPQ	Length (mm)	Width (mm)	Height (mm)
ı	DAC8802IPWR	TSSOP	PW	16	2000	350.0	350.0	43.0

# **PACKAGE MATERIALS INFORMATION**

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# **TUBE**



# \*All dimensions are nominal

Device	Package Name	Package Type	Pins	SPQ	L (mm)	W (mm)	T (µm)	B (mm)
DAC8802IPW	PW	TSSOP	16	90	530	10.2	3600	3.5
DAC8802IPWG4	PW	TSSOP	16	90	530	10.2	3600	3.5



SMALL OUTLINE PACKAGE



## NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.

  2. This drawing is subject to change without notice.

  3. This dimension does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall not
- exceed 0.15 mm per side.
- 4. This dimension does not include interlead flash. Interlead flash shall not exceed 0.25 mm per side.
- 5. Reference JEDEC registration MO-153.



SMALL OUTLINE PACKAGE



NOTES: (continued)

6. Publication IPC-7351 may have alternate designs.

7. Solder mask tolerances between and around signal pads can vary based on board fabrication site.



SMALL OUTLINE PACKAGE



NOTES: (continued)

- 8. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.
- 9. Board assembly site may have different recommendations for stencil design.



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